

<b>Notice of References Cited</b>	Application/Control No. 09/917,312	Applicant(s)/Patent Under Reexamination CHENG ET AL.	
	Examiner Shane F Gerstl	Art Unit 2183	Page 1 of 1

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**NON-PATENT DOCUMENTS**

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	U	The Authoritative Dictionary of IEEE Standards Terms, Standards Information Network, IEEE Press, 7th Edition, 2000, pages 767 and 933
	V	The Design of the Microarchitecture of UltraSPARC-I; Marc Tremblay, Dale Greenley, and Kevin Normoyle; Proceedings of the IEEE, Vol 83, No 12, December 1995
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.